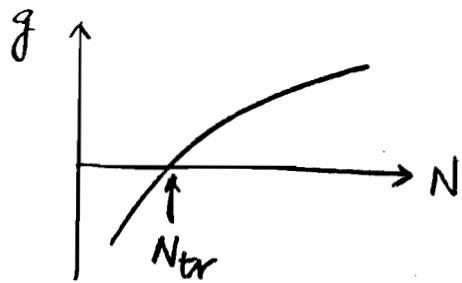


# Strained Quantum Wells



$$g = g_0 \cdot \ln \frac{N}{N_{tr}} \quad \text{for QW}$$

$$g_{th} = g_0 \ln \frac{N_{th}}{N_{tr}}$$

$$I_{th} = \frac{V_{active}}{2} \cdot \frac{N_{th}}{\tau} \cdot g$$

$\hookrightarrow \tau = \tau(N_{th})$

$$g = a(N - N_{tr}) \quad \text{for Bulk}$$

$$g_{th} = a(N_{th} - N_{tr})$$

$$N_{tr}(\text{QW}) \sim N_{tr}(\text{Bulk})$$

Reduction in threshold is mainly from the reduction in active volume (i.e. thickness)

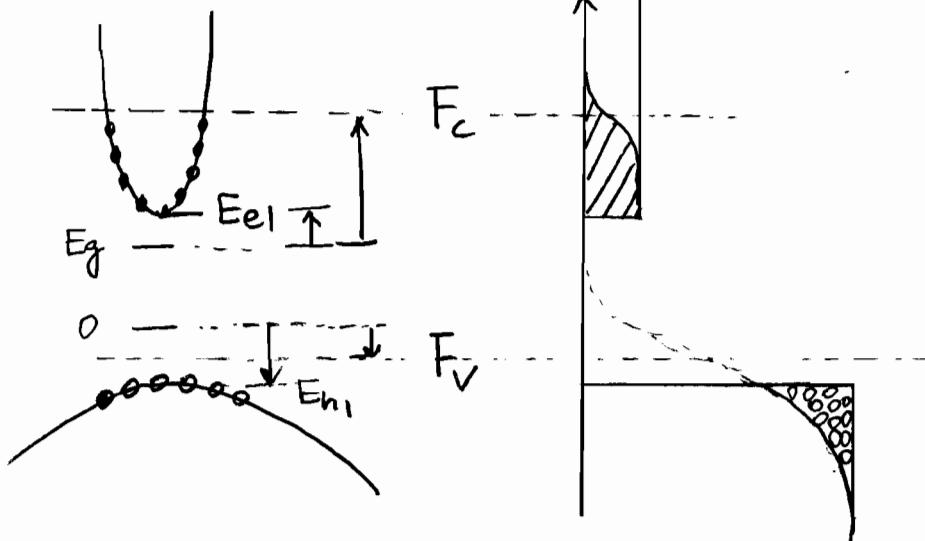
If  $N_{tr}$  can be reduced  $\rightarrow$  Further reduction of  $I_{th}$ .

What determines  $N_{tr}$ ?

# Influence of Effective Mass.

In most semiconductors.

$$m_h^* \gg m_e^*$$



Population condition (Bernard-Duraffourg)

$$p_h = \frac{m_h^*}{\pi \hbar^2 L_3}$$

$$F_C - F_v + E_g > \hbar \omega > E_g + E_{el} - E_{h1} (\equiv E_g^{\text{eff}})$$

\*Note: { The reference for  $F_C$ ,  $E_{el}$  is  $E_g$   
The " " "  $F_v$ ,  $E_{h1}$  is  $E_v = 0$

Since  $m_h^* \gg m_e^*$ ,  $F_v$  usually above  $E_{h1}$ ,

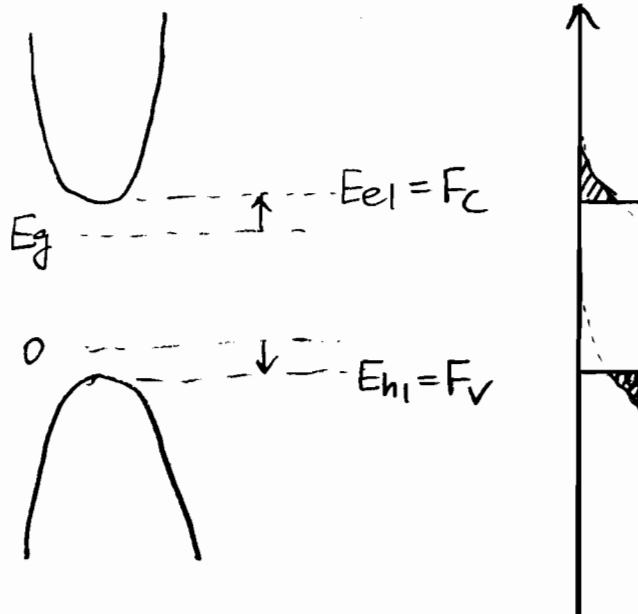
Ntr, the carrier concentration required to reach

$$F_C - F_v + E_g \geq E_g + E_{el} - E_{h1}$$

is large.

## Ideal semiconductor

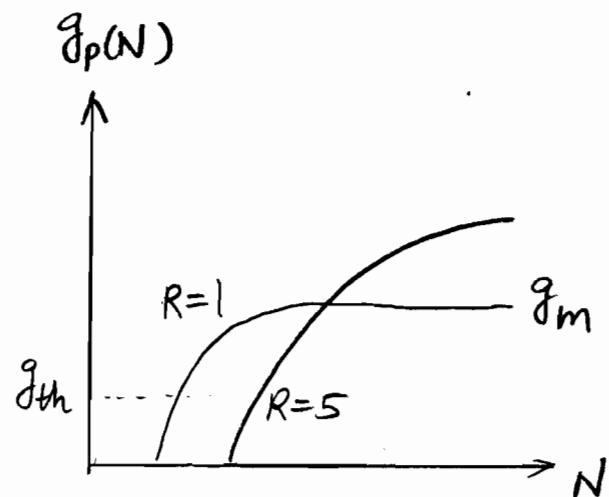
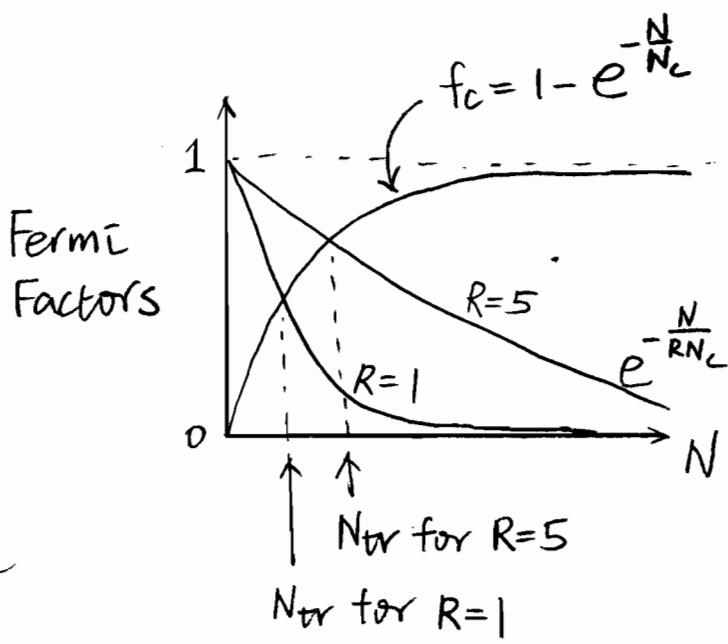
$$m_h^* = m_e^*$$



Mathematically

$$\begin{aligned} g_p(N) &= g_m (f_c - f_v) \\ &\approx g_m (1 - e^{-N/N_c} - e^{-N/RN_c}) \end{aligned}$$

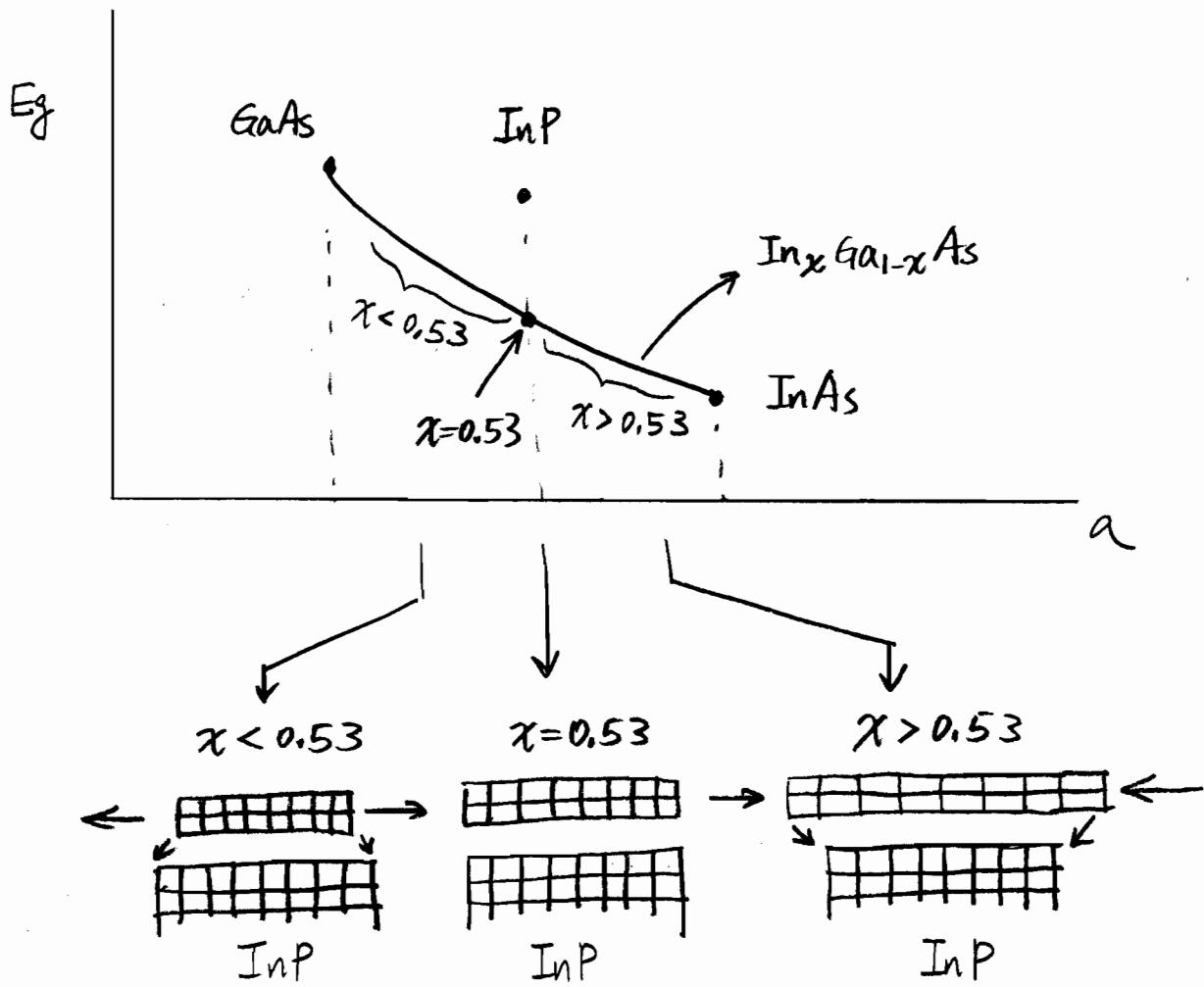
$$R = \frac{m_h^*}{m_e^*}$$



for  $g_{th} \ll g_m$

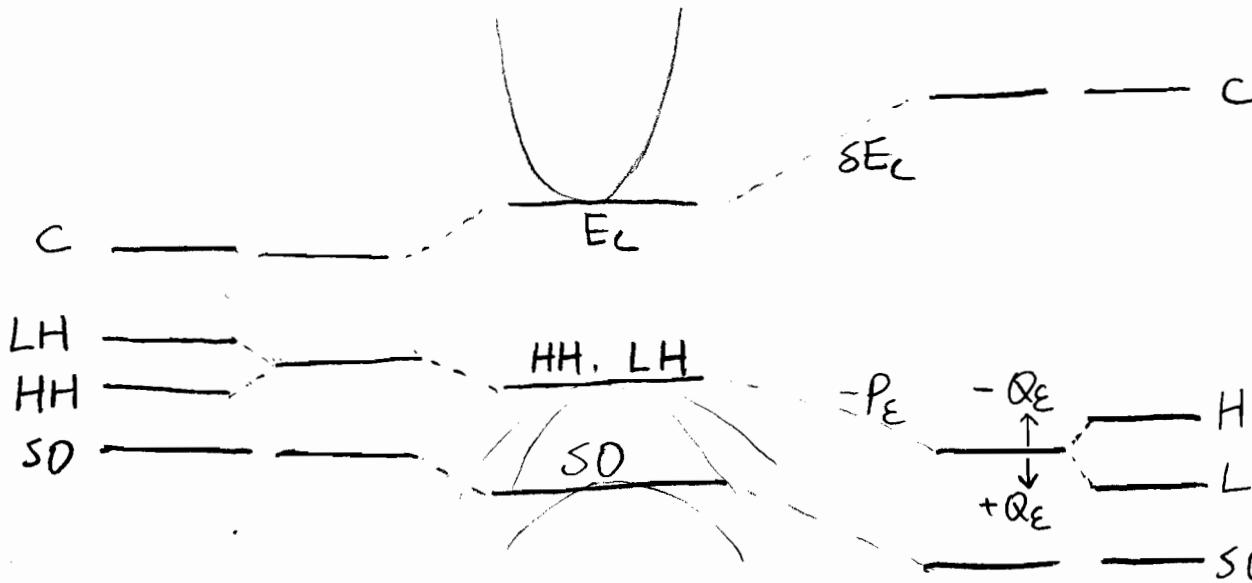
$R=1$  has lower  $N_{th}$  than  $R=5$

# Strain Effect



$In_x Ga_{1-x} As$  experience  
"tensile" strain

$In_x Ga_{1-x} As$  experience  
"compressive" strain



Tensile Strain  $\leftarrow$  Unstrained  $\rightarrow$  Compressive Strain

Ref. [Chuang pp. 440–448; Coldren pp. 530–536]

$$\text{Strain } \varepsilon = \varepsilon_{xx} = \varepsilon_{yy} = \frac{a_0 - a(x)}{a_0}$$

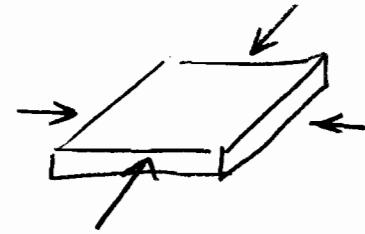
$a_0$  : lattice constant of InP.

$$\begin{cases} \varepsilon < 0 \text{ for compressive strain} \\ \varepsilon > 0 \text{ " tensile " } \end{cases}$$

$$\varepsilon_L = \varepsilon_{zz} = -2 \frac{C_{12}}{C_{11}} \varepsilon$$

↑  
Compliance Tensor  
 $C_{12} \approx 0.5 C_{11}$

$$\begin{bmatrix} \sigma_{xx} \\ \sigma_{yy} \\ \sigma_{zz} \end{bmatrix} = \begin{bmatrix} C_{11} & C_{12} & C_{12} \\ C_{12} & C_{11} & C_{12} \\ C_{12} & C_{12} & C_{11} \end{bmatrix} \begin{bmatrix} \epsilon_{xx} \\ \epsilon_{yy} \\ \epsilon_{zz} \end{bmatrix}$$



uniaxial stress

$$\sigma_{xx} = \sigma_{yy} = \sigma$$

$$\sigma_{zz} = 0$$

$$\epsilon_{xx} = \epsilon_{yy} = \epsilon$$

$$\sigma_{zz} = 0 \Rightarrow C_{12} \epsilon_{xx} + C_{12} \epsilon_{yy} + C_{11} \epsilon_{zz} = 0$$

$$\epsilon_{zz} = -2 \frac{C_{12}}{C_{11}} \epsilon$$

Band Edge Shift:

$$E_c = E_g(x) + \delta E_c$$

$$E_{HH} = -P_E - Q_E$$

$$E_{LL} = -P_E + Q_E$$

$$\delta E_c = a_c (\epsilon_{xx} + \epsilon_{yy} + \epsilon_{zz}) = 2 a_c \left(1 - \frac{C_{12}}{C_{11}}\right) \epsilon$$

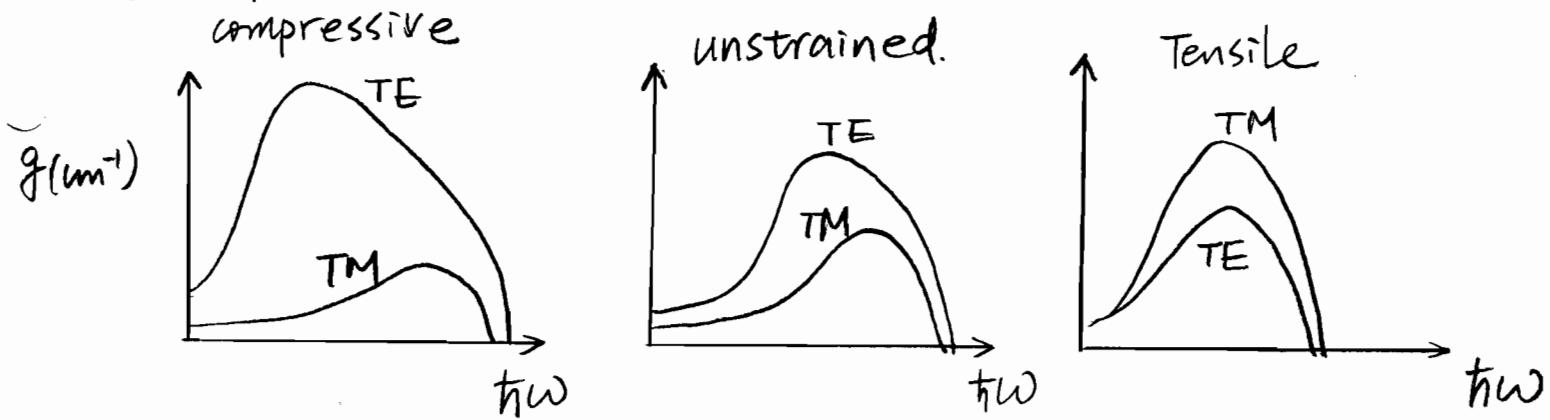
$$P_E = -a_v (\epsilon_{xx} + \epsilon_{yy} + \epsilon_{zz}) = -2 a_v \left(1 - \frac{C_{12}}{C_{11}}\right) \epsilon$$

$$Q_v = -\frac{b}{2} (\epsilon_{xx} + \epsilon_{yy} - 2\epsilon_{zz}) = -b \left(1 + 2 \frac{C_{12}}{C_{11}}\right) \epsilon$$

$a = a_c - a_v$  : hydrostatic potential

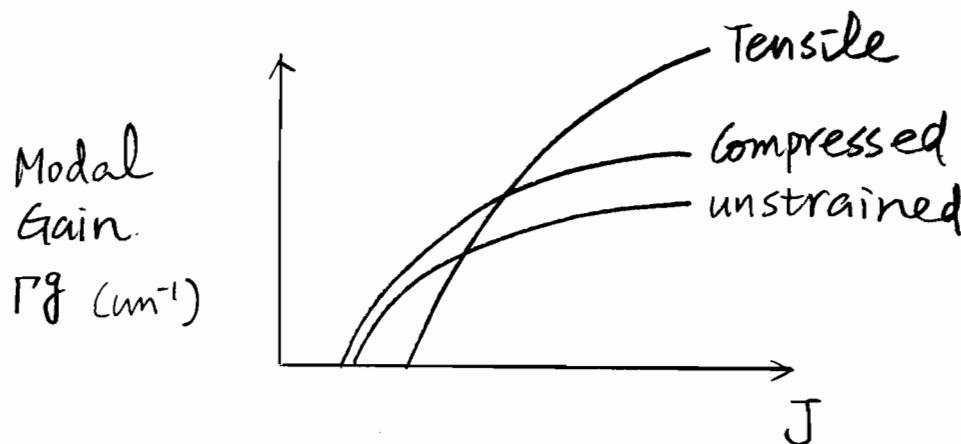
$b$  : shear potential

## Gain Spectra



Compressive strained and unstrained QW laser  
are TE polarized.

Tensile strained QW laser is TM polarized.



Compressive  $\rightarrow$  low threshold

Tensile.  $\rightarrow$  high gain (for semiconductor optical amplifier, SOA)